## Applicant(s)/Patent Under Application/Control No. Reexamination 10/686,098 LUKE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3672 George Suchfield **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 166/293 US-2662827 12-1953 Clark Α 06-1975 Quist et al 166/293 US-3887385 В 106/713 03-1984 Diehl et al. US-4,435,216 C 588/250 US-5980446 11-1999 Loomis D 175/64 US-6,702,044 03-2004 Reddy et al. Ε 106/737 08-2002 Ku, Richard US-2002/0117090 F 504/358 08-2003 Allen et al. G US-2003/0153466 106/819 US-2004/0040475 03-2004 De La Roij, Robin Н 166/293 09-2004 Reddy et al US-20040168803 1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Name Classification Country Country Code-Number-Kind Code MM-YYYY N 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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